


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576689	<b>Applicant(s)/Patent Under Reexamination</b>  LIU ET AL.
	<b>Examiner</b>  Bruck Kifle	<b>Art Unit</b>  1624

SEARCHED			
Class	Subclass	Date	Examiner
540	496	06/12/08	BK
514	220	06/12/08	BK

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
540	496	06/12/08	BK
514	220	06/12/08	BK